PXIe-6545

Specifications

Authorized
Distributor

Integration
Partner

Contents

PXIe-6545 Specifications

PXIe-6545 Specifications

This document provides the specifications for the PXIe-6545.

> ✎ **Note** All values were obtained using a 1 m cable (SHC68-C68-D4 recommended). Performance specifications are not guaranteed when using longer cables.

Definitions and Conditions

Specifications are valid for the range 0 °C to 55 °C unless otherwise noted.

Maximum and **minimum** specifications are warranted not to exceed these values within certain operating conditions and include the effects of temperature and uncertainty unless otherwise noted.

Typical specifications are unwarranted values that are representative of a majority (3σ) of units within certain operating conditions and include the effects of temperature and uncertainty unless otherwise noted.

Characteristic specifications are unwarranted values that are representative of an average unit operating at room temperature.

Nominal specifications are unwarranted values that are relevant to the use of the product and convey the expected performance of the product.

All specifications are Typical unless otherwise noted.

PXIe-6545 Pinout

The PXIe-6545 front panel exposes the following connections:

- Three SMA connectors named CLK IN, PFI 0, and CLK OUT

- One 68-pin VHDCI connector named DIGITAL DATA & CONTROL, or DDC

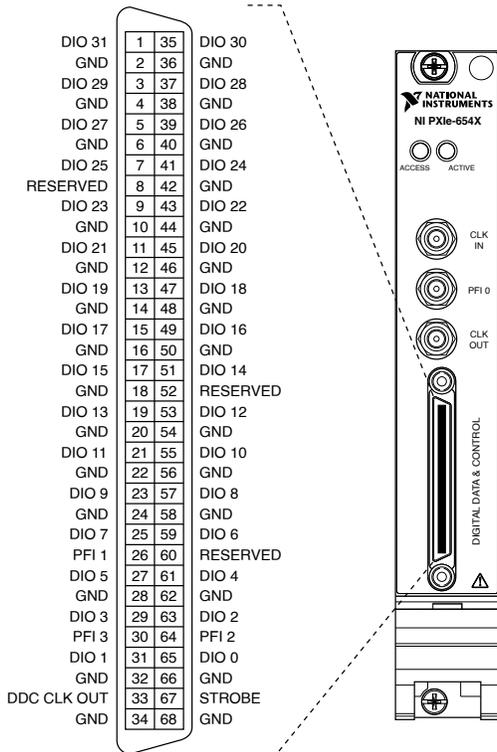Figure 1. PXIe-6545 Front Panel with VHDCI Connector Pinout

Table 1. PXIe-6545 DDC Connector Pins

Pins	Signal Name	Signal Type	Signal Description
33	DDC_CLK OUT	Control	Output terminal for the exported Sample Clock.
67	Strobe	Control	Terminal for the external Sample clock source, which can be used for dynamic acquisition.
1, 3, 5, 7, 9, 11, 13, 15, 17, 19, 21, 23, 25, 27, 29, 31, 35, 37, 39, 41, 43, 45, 47, 49, 51, 53, 55, 57, 59, 61, 63, 65	DIO <0..31>	Data	Bidirectional digital I/O data channels 0 through 31.
26, 30, 64	Programmable Function Interface (PFI) <1..3>	Control	Input terminals to the device for external triggers, or output terminals from the device for events.
2, 4, 6, 10, 12, 14, 16, 18, 20,	GND	Ground	Ground reference for signals.

Pins	Signal Name	Signal Type	Signal Description
22, 24, 28, 32, 34, 36, 38, 40, 42, 44, 46, 48, 50, 54, 56, 58, 62, 66			
8, 52, 60	RESERVED	N/A	Terminals reserved for future use. Do not connect to these pins.

Table 2. PXIe-6545 SMA Connectors

Connector	Signal Name	Signal Type	Description
CLK IN	Reference Clock Input	Control	Terminal for the external Reference clock used for the PLL or for the external Sample clock used for dynamic generation and/or acquisition.
PFI 0	PFI 0	Control	Single-ended input terminals to the device for static I/O, for external triggers, or for output terminals from the device for events. Refer to the device specifications for signal voltage levels.

Connector	Signal Name	Signal Type	Description
CLK OUT	Reference Clock Output	Control	Terminal for the exported PLL Reference clock or the exported Sample clock.

Channels

Data	
Number of channels	32, single data rate (SDR)[1]
Direction control	Per channel Per operation
Time to tristate (t_{PZ}), 2 kΩ and 15 pF load	6.2 ns, nominal
Programmable Function Interface (PFI)	
Number of channels	4
Direction control	Per channel
Clock terminals	
Input	2

1. Using SDR, data is clocked using the rising or falling edge of the Sample clock.

Output	2

Related reference:

- [Triggers](#)
- [Events](#)
- [CLK IN](#)
- [CLK OUT](#)

Generation Channels

Channels	Data DDC CLK OUT PFI <0..3>
Generation signal type	Single-ended
DC generation voltage accuracy[2]	±35 mV, typical ±200 mV, maximum

Table 3. Generation Voltage Levels

Logic Family[3]	Voltage Low Level (V_{OL})		Voltage High Level (V_{OH})		Accuracy for Nominal Values into 1 MΩ Load
	Nominal	Max	Min	Nominal	
1.2 V (V_{OH} = 1.2 V)	0.0 V	0.2 V	1 V	1.2 V	±35 mV, typical
1.5 V (V_{OH} = 1.5 V)			1.3 V	1.5 V	

2. Into 1 MΩ; does not include system crosstalk.
3. For all data, PFI, and clock channels. Does not include system crosstalk.

| Logic Family | Voltage Low Level (V_{OL}) | | Voltage High Level (V_{OH}) | | Accuracy for Nominal Values into 1 MΩ Load |
	Nominal	Max	Min	Nominal	
1.8 V (V_{OH} = 1.8 V)			1.6 V	1.8 V	
2.5 V (V_{OH} = 2.5 V)			2.3 V	2.5 V	
3.3 V (V_{OH} = 3.3 V)			3.1 V	3.3 V	

Note Generation and acquisition sessions share a common voltage resource. Simultaneous operations must be set to the same logic family.

Output impedance	50 Ω, nominal
Maximum allowed DC drive strength per channel, by logic family	
1.2 V	±12 mA, nominal
1.5 V	±15 mA, nominal
1.8 V	±18 mA, nominal
2.5 V	±25 mA, nominal
3.3 V	±33 mA, nominal
Data channel driver enable/disable control	Software-selectable: per channel

Channel power-on state	Drivers disabled, 50 kΩ nominal input impedance
Output protection	
Range	0 V to 5 V
Duration	Indefinite

Related reference:

- CLK OUT
- DDC CLK OUT

Acquisition Channels

Channels	Data STROBE PFI <0..3>
Acquisition signal type	Single-ended
Accuracy[4]	±150 mV, typical ±30%, maximum

4. Does not include system crosstalk.

Logic Family[5]	Voltage Thresholds Low (V_{IL})		Voltage Thresholds High (V_{IH})	
	Minimum	**Typical**	**Typical**	**Maximum**
1.2 V (V_{IH}, V_{IL} = 0.60 V)	420 mV	450 mV	750 mV	780 mV
1.5 V (V_{IH}, V_{IL} = 0.75 V)	525 mV	600 mV	900 mV	975 mV
1.8 V (V_{IH}, V_{IL} = 0.90 V)	630 mV	750 mV	1.05 V	1.17 V
2.5 V (V_{IH}, V_{IL} = 1.25 V)	875 mV	1.10 V	1.40 V	1.625 V
3.3 V (V_{IH}, V_{IL} = 1.65 V)	1.155 V	1.50 V	1.80 V	2.145 V

Note Generation and acquisition sessions share a common voltage resource. Simultaneous operations must be set to the same logic family.

Input impedance	High-impedance (50 kΩ), nominal
Input protection[6]	-1 V to 5 V

Timing

Sample Clock

Sources	1. On Board clock (internal 800 MHz VCO with 32-bit DDS)
	2. CLK IN (SMA jack connector)
	3. STROBE (Digital Data & Control [DDC] connector; acquisition only)

5. For all data, PFI, and clock channels. Does not include system crosstalk.
6. Internal diode clamps may begin conduction outside the -0.5 V to 3.5 V range.

Frequency range	
On Board clock	100 Hz to 200 MHz
CLK IN	20 kHz to 200 MHz
STROBE	100 Hz to 200 MHz

On Board clock characteristics	
Resolution[7]	0.2 Hz, maximum
Accuracy[8]	±150 ppm + 5 ppm per year

On Board clock characteristics valid only when PLL reference source is set to None	
Frequency accuracy	±150 ppm (including temperature effects), typical
Aging	±5 ppm first year, nominal

| Sample clock relative delay adjustment[9]	
Range	
Acquisition sessions	0.0 to 1.0 Sample clock periods
Generation sessions	0.0 ns to 5.0 ns
Resolution	0.5 ps

7. Varies with Sample clock frequency. You can query NI-HSDIO for the programmed frequency value.
8. Accuracy may be increased by using a higher-performance external Reference clock.
9. You can apply a delay or phase adjustment to the On Board clock to align multiple devices.

Exported Sample clock destinations	DDC CLK OUT (DDC connector) CLK OUT (SMA jack connector)
Exported Sample clock delay	
Range	0.0 to 1.0 Sample clock periods
Resolution (δ_C)[10]	117 ps to 143 ps, nominal
Frequency	
On Board clock	All supported frequencies
External clock	Frequencies ≥20 MHz
Exported Sample clock jitter, using On Board clock	
Period	24 ps$_{rms}$, characteristic
Cycle-to-cycle	43 ps$_{rms}$, characteristic

Figure 2. Characteristic Period Jitter (RMS) vs. Frequency
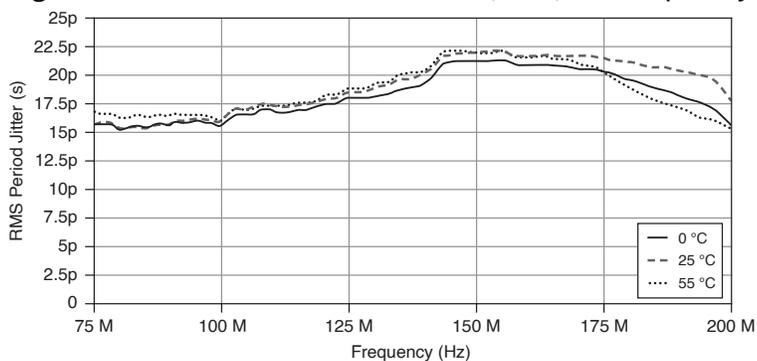
10. Resolution is nonlinearly dependent on clock frequency. You can query clock frequency using NI-HSDIO.

Related reference:

- CLK IN
- STROBE

Generation Timing

| Channels	Data DDC CLK OUT PFI <0..3>
Data channel-to-channel skew[11]	±300 ps, maximum
Maximum data rate per channel	
SDR	100 Mbps

> **Note** Includes maximum data channel-to-channel skew and typical crosstalk.

The following figure shows an eye diagram of a 400 Mbps pseudorandom bit sequence (PRBS) waveform in DDR mode at 3.3 V. This waveform was captured on DIO 0 at room temperature into high impedance.

11. Maximum skew across all data channels, PFI channels, and voltage levels when using the same data position or data delay bank.

Figure 3. Characteristic Eye Diagram (High Impedance)
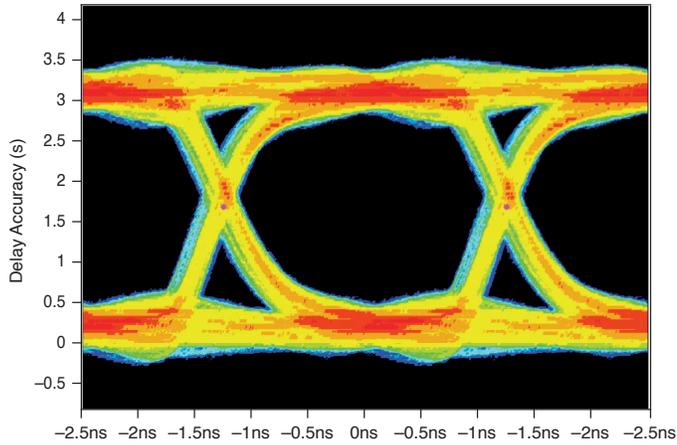
The following figure shows an eye diagram of a 400 Mbps PRBS waveform in DDR mode at 3.3 V. This waveform was captured on DIO 0 at room temperature into 50 Ω termination.

Figure 4. Characteristic Eye Diagram (50 Ω Termination, characteristic)
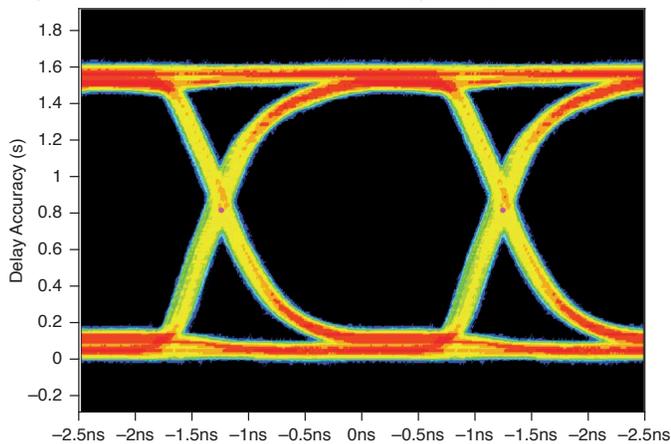
Data position modes	Sample clock rising edge
	Sample clock falling edge
	Delay from Sample clock rising edge
Data delay banks	1 bank for all channels and PFI lines
Generation data delay	

Range (δ_G)	0.0 to 1.0 Sample clock periods
Resolution (δ_G)[12]	117 ps to 143 ps, nominal
Frequency	
On Board clock	All supported frequencies
External clock	Frequencies ≥20 MHz

Figure 5. Characteristic Data Delay Accuracy
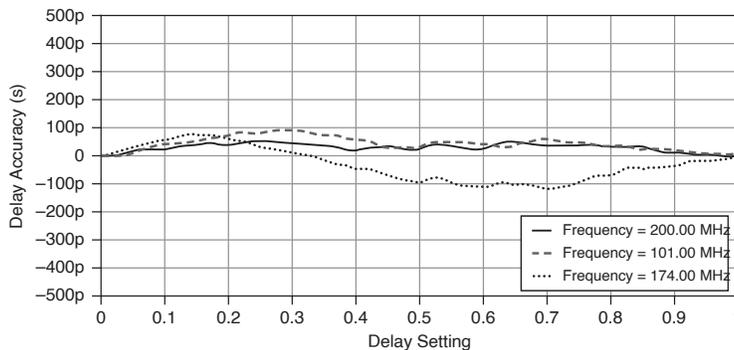
Exported Sample clock offset (t_{CO})	0.0 ns or 1.65 ns (default),[13] nominal
Time delay from On Board Sample clock to DDC connector (t_{SCDDC})	8.1 ns, characteristic; exported Sample clock offset = 0 ns

Generation Provided Setup and Hold Times

Compare the setup and hold times from the datasheet of your device under test (DUT) to the values in the table. The provided setup and hold times must be greater than the setup and hold times required for the DUT. If you require more setup time, configure

12. Resolution is nonlinearly dependent on clock frequency. You can query resolution using NI-HSDIO.
13. Software-selectable for DDC CLK OUT.

your exported Sample clock mode to Inverted and/or delay your clock or data relative to the Sample clock. This table includes worst-case effects of channel-to-channel skew and intersymbol interference.

Exported Sample Clock Offset (t_{PCO})	Minimum Provided Setup Time (t_{PSU})	Minimum Provided Hold Time (t_{PH})
1.65 ns	t_p - 2.15 ns	1.15 ns
0.0 ns	t_p - 500 ps	-500 ps

Note This table assumes the data position is set to Sample clock rising edge and the noninverted Sample Clock is exported to the DDC connector.

Figure 6. Generation Provided Setup and Hold Times Timing Diagram
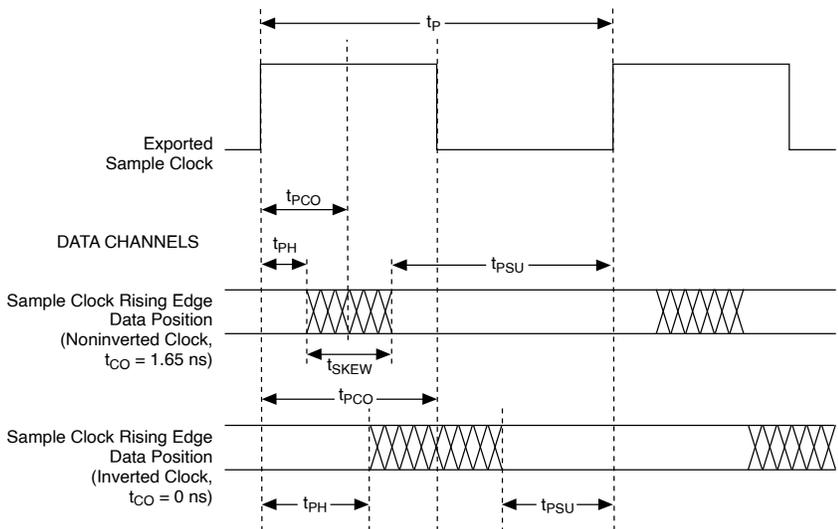
$t_P = \dfrac{1}{f}$ = Sample Clock Period

t_{PH} = Minimum Provided Hold Time
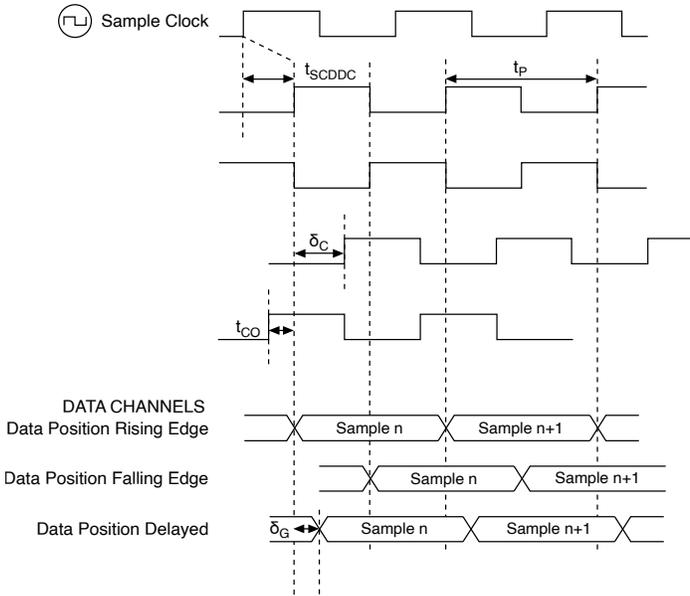
t_{PSU} = Minimum Provided Set-Up Time

t_{PCO} = Time from Rising Clock Edge to Data Transition (Provided Clock to Out Time)

t_{CO} = Exported Sample Clock Offset

t_{SKEW} = Maximum Channel-to-Channel Skew and Clock Uncertainty

Note Provided setup and hold times account for maximum channel-to-channel skew and jitter.

Figure 7. Generation Timing Diagram

t_{SCDDC} : Time Delay from Sample Clock (Internal) to DDC Connector

$0 \le \delta_C \le 1$: Exported Sample Clock Delay (Fraction of t_P)

$0 \le \delta_G \le 1$: Pattern Generation Data Delay (Fraction of t_P)

$t_P = \frac{1}{f}$ = Period of Sample Clock

t_{CO} = Exported Sample Clock Offset; 1.65 ns, Software-Selectable

Acquisition Timing

Channels	Data STROBE PFI <0..3>
Channel-to-channel skew[14]	±350 ps, maximum
Maximum data rate per channel[15]	
SDR	100 Mbps
Data position modes	Sample clock rising edge

14. Across all data channels, PFI channels, and voltage levels.
15. Includes maximum data channel-to-channel skew and typical crosstalk.

	Sample clock falling edge Delay from Sample clock rising edge

Table 4. Setup and Hold Times to STROBE, Characteristic[16]

Voltage Threshold	Setup Time (t_{sus})		Hold Time (t_{hs})	
	ƒ <20 MHz	ƒ ≥20 MHz	ƒ <20 MHz	ƒ ≥20 MHz
1.25 V to 1.65 V	2.8 ns	1.15 ns	2.4 ns	900 ps
0.90 V to 1.20 V		1.20 ns		1.00 ns
0.75 V to 0.85 V		1.40 ns		1.10 ns
0.60 V to 0.70 V		1.75 ns		1.25 ns

Setup and hold times to Sample clock[17]	
Setup time (t_{susc})	900 ps, nominal
Hold time (t_{HSC})	425 ps, nominal
Data delay banks	1 bank for all channels and PFI lines
Time delay from DDC connector to internal Sample clock	6.8 ns, nominal
Acquisition data delay	
Frequency	

16. Includes maximum data channel-to-channel skew and uncertainty, but does not include system crosstalk. Performance may vary with system crosstalk performance.
17. Does not include channel-to-channel skew, t_{DDCSC}, or t_{SCDDC}

On Board clock	All supported frequencies
External clock and STROBE	Frequencies ≥20 MHz
Range	0.0 to 1.0 Sample clock periods
Resolution[18]	117 ps to 143 ps, nominal

Figure 8. Acquisition Timing Diagram Using STROBE as the Sample Clock
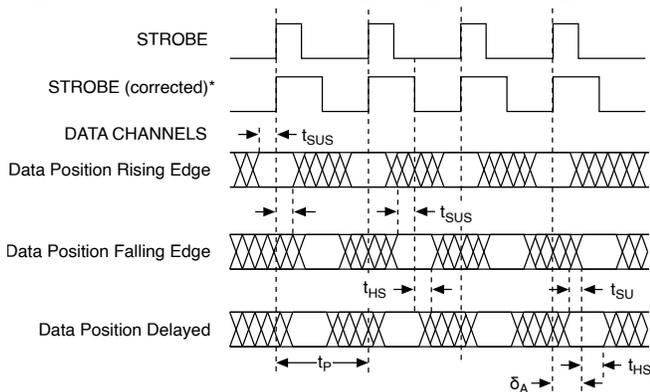
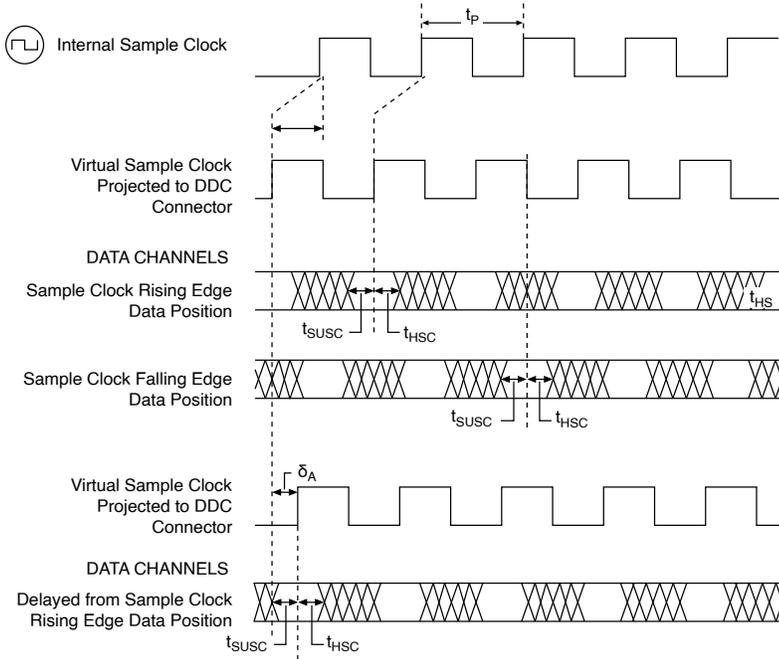t_{SUS} = Set-Up Time to STROBE

t_{HS} = Hold Time from STROBE

$0 \leq \delta_A \leq 1$: Acquisition Data Delay (fraction of t_P)

$t_P = \dfrac{1}{f}$ = Sample Clock Period

*Note: When using an external Sample clock greater than 20 MHz, the duty cycle is corrected to 50%.

18. Resolution is nonlinearly dependent on clock frequency. You can query resolution using NI-HSDIO.

Figure 9. Acquisition Timing Diagram with Sample Clock Sources Other than STROBE

t_{DDCSC} : Time Delay from DDC Connector to Internal Sample Clock

$0 \leq \delta_A \leq 1$: Acquisition Data Delay (fraction of t_P)

$t_P = \dfrac{1}{f}$ = Period of Sample Clock

t_{SUSC} = Set-Up Time to Sample Clock

t_{HSC} = Hold Time to Sample Clock

Related reference:

- STROBE

CLK IN

Connector	SMA jack
Direction	Input
Destinations	1. Reference clock (PLL) 2. Sample clock

Input coupling	AC
Input protection	±10 VDC, nominal
Input impedance	Software-selectable: 50 Ω (default) or 1 kΩ, nominal
Minimum detectable pulse width	2 ns, nominal
Clock requirements	Free-running (continuous) clock

Waveform Voltage Ranges

Square wave voltage range	0.65 V_{pk-pk} to 5.0 V_{pk-pk}

Table 5. Sine Wave Voltage Ranges

Voltage Range (V_{pk-pk})	Frequency Range
0.65 to 5.0	20 MHz to 200 MHz
1.0 to 5.0	13 MHz to 200 MHz
1.3 to 5.0	10 MHz to 200 MHz
2.6 to 5.0	5 MHz to 200 MHz

CLK IN Implementations

As Sample clock[19]	
Frequency range	20 kHz to 200 MHz

Duty cycle range	
ƒ <20 MHz	25% to 75%
ƒ ≥20 MHz	40% to 60%

As Reference clock	
Frequency range	5 MHz to 100 MHz (integer multiples of 1 MHz)
Frequency accuracy[20]	±0.1%
Duty cycle range	25% to 75%

Related reference:

- [Channels](#)
- [Sample Clock](#)

STROBE

Connector	DDC
Direction	Input
Destination	Sample clock (acquisition only)
Frequency range	100 Hz to 200 MHz

19. Nominal 3 dB cutoff point at 100 MHz when using 1 kΩ input impedance.
20. Required accuracy of the external Reference clock source.

Duty cycle range (at the programmed threshold)	
f <20 MHz	25% to 75%
f ≥20 MHz	40% to 60% (corrected to 50%)
Minimum detectable pulse width[21]	2 ns, nominal
Clock requirements	Free-running (continuous) clock
Input impedance	50 kΩ, nominal

Related reference:

- Sample Clock
- Acquisition Timing

CLK OUT

Connector	SMA jack
Direction	Output
Sources	1. Sample clock (excluding STROBE) 2. Reference clock (PLL)
Output impedance	50 Ω, nominal

21. Required at acquisition voltage thresholds.

Logic type	Matched with generation and acquisition sessions

Related reference:

- [Channels](#)
- [Generation Channels](#)

DDC CLK OUT

Connector	DDC
Direction	Output
Source	Sample clock (generation only)

> ✏️ **Note** STROBE and acquisition Sample clock cannot be routed to DDC CLK OUT.

Related reference:

- [Generation Channels](#)

Reference Clock (PLL)

Sources[22]	1. PXI_CLK100 (PXI Express backplane) 2. CLK IN (SMA jack connector) 3. None (internal oscillator locked to an internal reference)

22. Provides the frequency for the PLL.

Destination	CLK OUT (SMA jack connector)
Lock time	150 ms, maximum (not including software latency)
Frequency range	5 MHz to 100 MHz (integer multiples of 1 MHz), 0.1% required accuracy
Duty cycle range	25% to 75%

Waveform

Memory and Scripting

Memory architecture	This device uses the Synchronization and Memory Core (SMC) technology in which waveforms and instructions share onboard memory. Parameters such as number of script instructions, maximum number of waveforms in memory, and number of samples (S) available for waveform storage are flexible and user defined.

Onboard memory size[23]

1 Mbit per channel

Acquisition	1 Mbit per channel (4 MBytes total)
Generation	1 Mbit per channel (4 MBytes total)

8 Mbit per channel

Acquisition	8 Mbit per channel (32 MBytes total)
Generation	8 Mbit per channel (32 MBytes total)

23. Maximum limit for generation sessions assumes no scripting instructions.

64 Mbit per channel	
Acquisition	64 Mbit per channel (256 MBytes total)
Generation	64 Mbit per channel (256 MBytes total)

Generation	
Single-waveform mode	Generates a single waveform once, n times, or continuously
Scripted mode[24]	Generates a simple or complex sequence of waveforms.
Finite repeat count	1 to 16,777,216

Waveform quantum[25]	
Data width = 4	1 sample
Data width = 2	2 samples

Waveform block size (in physical memory)	
Data width = 4	32 samples
Data width = 2	64 samples

24. Use scripts to describe the waveforms to be generated, the order in which the waveforms are generated, how many times the waveforms are generated, and how the device responds to Script Triggers.
25. DDR mode sets data width to 2.

Table 6. Generation Minimum Waveform Size[26]

Configuration	Sample Rate	
	200 MHz	100 MHz
Single waveform	1 S	1 S
Continuous waveform	128 S	64 S
Stepped sequence	128 S	64 S
Burst sequence	1056 S	512 S

Acquisition	
Minimum waveform size[27]	1 S
Record quantum	1 S
Total number of records[28]	2,147,483,647
Total pre-Reference trigger samples	0 up to full record
Total post-Reference trigger samples	0 up to full record

Triggers

Types	Sessions	Edge Detection	Level Detection
1. Start	Acquisition and generation	Rising or falling	—
2. Pause	Acquisition and generation	—	High or low

26. Sample rate dependent. Increasing sample rate increases minimum waveform size requirement.
27. Regardless of waveform size, NI-HSDIO allocates at least 640 bytes for a record.
28. The session should fetch quickly enough that unfetched data is not overwritten.

Types	Sessions	Edge Detection	Level Detection
3. Script <0..3>	Acquisition	Rising or falling	High or low
4. Reference	Acquisition	Rising or falling	—
5. Advance	Acquisition	Rising or falling	—
6. Stop	Generation	Rising or falling	—

Sources	1. PFI 0 (SMA jack connector) 2. PFI <1..3> (DDC connector) 3. PXI_TRIG <0..7> (PXI Express backplane) 4. Pattern match (acquisition sessions only) 5. Software (user function call) 6. Disabled (do not wait for a trigger)
Destinations, excluding Pause trigger[29]	1. PFI 0 (SMA jack connector) 2. PFI <1..3> (DDC connector) 3. PXI_TRIG <0..6> (PXI Express backplane)
Minimum required trigger pulse width	15 ns
Trigger rearm time	
Start to Reference trigger	150 S, maximum

29. Each trigger can be routed to any destination except the Pause trigger. The Pause trigger cannot be exported.

Start to Advance trigger	220 S, maximum
Advance to Advance trigger	220 S, maximum
Reference to Reference trigger	220 S, maximum

Delay from Pause trigger to Pause state and Stop trigger to Done state[30]		
Generation sessions	50 Sample clock periods + 300 ns, maximum	
Acquisition sessions	Synchronous with the data	
Delay from Start trigger and Script trigger to digital data output	3 Sample clock periods + 600 ns, maximum	

Related reference:

- [Channels](#)

Events

Types	Sessions
1. Marker <0..2>	Generation
2. Data Active	Generation
3. Ready for Start	Acquisition and generation
4. Ready for Advance	Acquisition
5. End of Record	Acquisition

30. Use the Data Active event during generation to determine on a sample-by-sample basis when the device enters the Pause or Done states.

Destinations (excluding Data Active event)[31]	1. PFI 0 (SMA jack connectors)
	2. PFI <1..3> (DDC connector)
	3. PXI_TRIG <0..6> (PXI Express backplane)

Marker time resolution (placement)	
SDR	Can be placed at any sample
DDR	Must be placed at an integer multiple of two samples

Related reference:

- [Channels](#)

Software

Driver Software

Driver support for this device was first available in NI-HSDIO 1.6.

NI-HSDIO is an IVI-compliant driver that allows you to configure, control, and calibrate the PXIe-6545. NI-HSDIO provides application programming interfaces for many development environments.

Application Software

NI-HSDIO provides programming interfaces, documentation, and examples for the following application development environments:

- LabVIEW
- LabWindows™/CVI™
- Measurement Studio
- Microsoft Visual C/C++

31. The Data Active event can only be routed to the PFI channels.

- .NET (C# and VB.NET)

NI Measurement Automation Explorer

NI Measurement Automation Explorer (MAX) provides interactive configuration and test tools for the PXIe-6545. MAX is included on the NI-HSDIO media.

Power

> **Note** Characteristic results are commensurate with an average user application using all data channels into high impedance load. Maximum results include worst-case data pattern.

VDC	Current, Characteristic	Current, Maximum
+3.3 V	1.75 A	1.77 A
+12 V	2.2 A	2.3 A

Total power	32.2 W, characteristic 33.5 W, maximum
Warm-up time	15 minutes

Physical

Dimensions	Single 3U, CompactPCI Express slot, PXI Express compatible 21.6 cm × 2.0 cm × 13.0 cm
Weight	519 g (18.3 oz)

I/O Panel Connectors

Label	Connector Type	Description
CLK IN		External Sample clock, external Reference clock
PFI 0	SMA jack	Events, triggers
CLK OUT		External Sample clock, exported Reference clock
DIGITAL DATA & CONTROL	68-pin VHDCI	Digital data channels, exported Sample clock, STROBE, events, triggers

Environment

> **Note** To ensure that the PXIe-6545 cools effectively, follow the guidelines in the *Maintain Forced Air Cooling Note to Users* included with the PXIe-6545 or available at ni.com/manuals. The PXIe-6545 is intended for indoor use only.

Operating temperature	0 °C to 55 °C in all NI PXI Express chassis and hybrid NI PXI Express chassis
Operating relative humidity	10 to 90% relative humidity, noncondensing (meets IEC 60068-2-56)
Storage temperature	-20 °C to 70 °C
Storage relative humidity	5 to 95% relative humidity, noncondensing (meets IEC 60068-2-56)

Operating shock	30 g, half-sine, 11 ms pulse (meets IEC 60068-2-27; test profile developed in accordance with MIL-PRF-28800F)
Operating vibration	5 Hz to 500 Hz, 0.31 g_{rms} (meets IEC 60068-2-64)
Storage shock	50 g, half-sine, 11 ms pulse (meets IEC 60068-2-27; test profile developed in accordance with MIL-PRF-28800F)
Storage vibration	5 Hz to 500 Hz, 2.46 g_{rms} (meets IEC 60068-2-64; test profile exceeds requirements of MIL-PRF-28800F, Class B)
Altitude	0 to 2,000 m above sea level (at 25 °C ambient temperature)
Pollution degree	2

Compliance and Certifications

Safety Compliance Standards

This product is designed to meet the requirements of the following electrical equipment safety standards for measurement, control, and laboratory use:

- IEC 61010-1, EN 61010-1
- UL 61010-1, CSA C22.2 No. 61010-1

> **Note** For safety certifications, refer to the product label or the Product Certifications and Declarations section.

Electromagnetic Compatibility

This product meets the requirements of the following EMC standards for electrical

equipment for measurement, control, and laboratory use:

- EN 61326-1 (IEC 61326-1): Class A emissions; Basic immunity
- EN 55011 (CISPR 11): Group 1, Class A emissions
- EN 55022 (CISPR 22): Class A emissions
- EN 55024 (CISPR 24): Immunity
- AS/NZS CISPR 11: Group 1, Class A emissions
- AS/NZS CISPR 22: Class A emissions
- FCC 47 CFR Part 15B: Class A emissions
- ICES-001: Class A emissions

Note In the United States (per FCC 47 CFR), Class A equipment is intended for use in commercial, light-industrial, and heavy-industrial locations. In Europe, Canada, Australia, and New Zealand (per CISPR 11), Class A equipment is intended for use only in heavy-industrial locations.

Note Group 1 equipment (per CISPR 11) is any industrial, scientific, or medical equipment that does not intentionally generate radio frequency energy for the treatment of material or inspection/analysis purposes.

Note For EMC declarations, certifications, and additional information, refer to **Product Certifications and Declarations**.

Notice Refer to the **Read Me First: Safety and Electromagnetic Compatibility** document for important safety and electromagnetic compatibility information. To obtain a copy of this document online, visit ni.com/manuals and search for the document title.

Notice To ensure the specified EMC performance, operate this product only with shielded cables and accessories. Do not use unshielded cables or accessories unless they are installed in a shielded enclosure with properly designed and shielded input/output ports and connected to the product using a shielded cable. If unshielded cables or accessories are not properly installed and shielded, the EMC specifications for the product are no longer

> guaranteed.

> ✏️ **Note** SHC68-C68-D4 shielded cable and the provided snap-on ferrite beads, National Instruments part number 711627-01, must be used when operating the PXIe-6545.

> ⊘ **Notice** To ensure the specified EMC performance, the length of all I/O cables must be no longer than 3 m (10 ft).

> ⊘ **Notice** To ensure the specified EMC performance, you must install PXI EMC Filler Panels, National Instruments part number 778700-01, in all open chassis slots.

CE Compliance C €

This product meets the essential requirements of applicable European Directives, as follows:

- 2014/35/EU; Low-Voltage Directive (safety)
- 2014/30/EU; Electromagnetic Compatibility Directive (EMC)
- 2011/65/EU; Restriction of Hazardous Substances (RoHS)
- 2014/53/EU; Radio Equipment Directive (RED)
- 2014/34/EU; Potentially Explosive Atmospheres (ATEX)

Product Certifications and Declarations

Refer to the product Declaration of Conformity (DoC) for additional regulatory compliance information. To obtain product certifications and the DoC for NI products, visit ni.com/product-certifications, search by model number, and click the appropriate link.

Environmental Management

NI is committed to designing and manufacturing products in an environmentally responsible manner. NI recognizes that eliminating certain hazardous substances from our products is beneficial to the environment and to NI customers.

For additional environmental information, refer to the ***Engineering a Healthy Planet*** web page at ni.com/environment. This page contains the environmental regulations and directives with which NI complies, as well as other environmental information not included in this document.

EU and UK Customers

- ⊠ **Waste Electrical and Electronic Equipment (WEEE)**—At the end of the product life cycle, all NI products must be disposed of according to local laws and regulations. For more information about how to recycle NI products in your region, visit ni.com/environment/weee.

电子信息产品污染控制管理办法（中国RoHS）

- ⊚⊚⊚ **中国RoHS**— NI符合中国电子信息产品中限制使用某些有害物质指令 (RoHS)。关于NI中国RoHS合规性信息，请登录 `ni.com/environment/rohs_china`。(For information about China RoHS compliance, go to `ni.com/environment/rohs_china`.)